

# AN4233 Application note

Sound Terminal<sup>®</sup>: a method for measuring the total thermal resistance (R<sub>th</sub>) in the final application

By Marco Brugora

## Introduction

The purpose of this document is to provide a methodology for measuring the total thermal resistance junction-to-ambient ( $R_{th j-a}$ ) of a Sound Terminal<sup>®</sup> amplifier in a final application. The methodology allows identifying  $R_{th}$ , considering the effect of the PCB and in particular the influence of the GND plane, the number of layers of the board, and the copper connective paths.

# Contents

1	Desc	cription
	1.1	Equipment needed and HW and SW configuration
	1.2	Test procedure
2	Sche	ematic diagram
3	Test	results with the STA333IS and 2- or 4-layer PCB
	3.1	STA333IS: 500 mA output current and 2-layer PCB 6
	3.2	STA333IS: 1000 mA output current and 2-layer PCB
	3.3	STA333IS: 500 mA output current and 4-layer PCB
	3.4	STA333IS: 1000 mA output current and 4-layer PCB
4	Con	clusion
5	Revi	sion history



## 1 Description

As mentioned, this test methodology allows measuring with high accuracy  $R_{th j-a}$  of the Sound Terminal<sup>®</sup> amplifier when it is assembled in a PCB.

To perform the test it is not necessary to modify the hardware in the final application although some registers must be configured in order to have the appropriate setup of the device.

Setting the registers to have ternary modulation and with no input signal (or amplitude < -60 dBFs), each output of the power stage will be set to GND. Connecting the output to a positive source and with a resistor connected in series to limit the current, it is possible to sink a DC current from the output. A reliable and cheap method to measure the output current is to convert the current to voltage using a high-precision sense resistor (for instance 0.1  $\Omega$ ) connected in series to each output. Using a voltmeter it is possible to also measure the voltage level on the output of each bridge and this information, along with the current level, allows calculating with high accurancy the RDSon of each power output (only for the low-side portion of the output bridge).

## **1.1 Equipment needed and HW and SW configuration**

To perform the measurement, the equipment and the settings are summarized as follows:

Register setting: the device must be set to have TERNARY modulation scheme.

**Output loads**: four dummy resistors must be connected to each bridge output and connected to a positive supply voltage (Vdd or Vcc).

**Input signal**: it must be null or < -60 dBFs.

High precision resistor ( $R_{sense}$ ): four sense resistors with very low resistive value (for instance 0.1  $\Omega$ ) must be connected in series between each output and the load. These will be used to read the current ( $I_{out} = V_{Rsense}/R_{sense}$ )

**Current meter (DC)**: a current meter must be inserted in series to each supply sources; specifically Vdd (+3.3 V) and Vcc must be monitored. The series resistance of this equipment must be very low to avoid adding any unwanted voltage drop.

**Voltmeters (DC)**: a voltmeter will be used to measure both Vdd and Vcc after the current meter and to measure the voltage across each sense resistor. The accuracy of this equipment must be precise enough to measure the low voltage levels present across each sense resistor. This equipment will be used to measure  $V_{\text{Rsense}}$  and  $V_{\text{out}}$ .

**Thermal camera**: a thermal camera must be used to measure the device temperature. Care must be taken to avoid any possible mistake during the temperature measurement; it is mandatory to define the right emission coefficient and to avoid reflection from the device package (special paint could be used or a small portion of non-reflective tape could be applied on top of the case). It is mandatory to use a thermal camera with a resolution high enough to discriminate the surface of the device. It is not recommended to use an IR thermometer because with this tool it is not possible to measure with sufficient precision the device due to the optical angle and also the position of the beam.

From the description above it is clear that all the measurements have been performed in the DC domain. This aspect is very important because whatever parasitic effects due to the PWM switching signal will be cancelled as well as the losses in the snubber networks,



output dumping network and in the magnetic materials, all of which are usually difficult to estimate.

## 1.2 Test procedure

The steps to perform the test are as follows:

- 1. Connect the board to the supply generators (Vcc, Vdd; Vdd could be provided by the APWlink if this board is connected to the DUT)
- 2. Connect the outputs to the series made by the sense resistors and limiter resistors to a positive supply source. The voltage source could be the same used to supply the device (Vcc), in this manner simplifying the connections and the number of PSUs. The limiter resistor must be selected to reach the target current to sink from each output.
- 3. Set the digital input to have no audio input signal.
- 4. Turn on the PSUs.
- 5. Set the device register to have a TERNARY modulation. This action could be executed using an APWlink board and the APWorkbench software.
- 6. Measure using the voltmeter each supply voltage and adjust the level if it is too low due to the additional voltage drop caused by the current meter internal resistance.
- 7. Read the current sunk from each supply source.
- 8. With a voltmeter, for each output measure the voltage across the sense resistor (this level allows knowing the output current) and the voltage between the output pin and GND. This last measurement allows measuring the voltage drop inside the device due to RDSon. The measurement must be carried out, positioning the voltage probe as close as possible to the output pin or output ball to avoid any voltage drop due to the copper track.
- 9. With the thermal camera measure the device temperature. It is mandatory to wait to have a stable measurement and then save the thermal picture.

The above sequence can be repeated, setting some output current levels and modifying the Vcc supply level.



## 2 Schematic diagram

AN4233

*Figure 1* shows the schematic diagram which indicates the current meters connected in series to Vdd and Vcc and the 8 test points dedicated to measure  $V_R_{sense}$  and the Vout level for each channel.

Rs1 through Rs4 are the sense resistors and R1 through R4 are the resistors used to limit the current flowing from Vcc to the output.

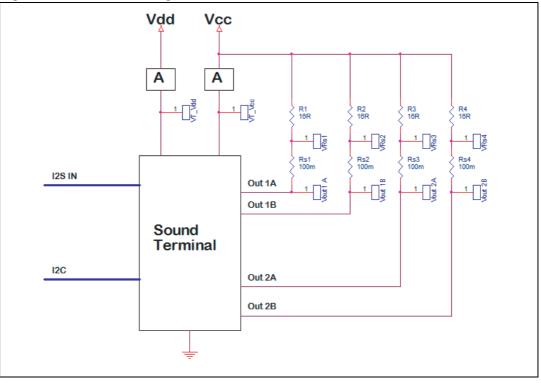


Figure 1. Schematic diagram



#### Test results with the STA333IS and 2- or 4-layer PCB 3

The following examples show the results achieved when testing the STA333IS device assembled in two different boards, the first one has 2 layers while the second one has 4 layers. The test has also been performed with two different output current levels (500 mA and 1000 mA) for each board.

#### 3.1 STA333IS: 500 mA output current and 2-layer PCB

V\_R<sub>sense</sub> R<sub>sense</sub> I\_Channel Vcc I Vcc I Vdd V<sub>RDS</sub> RDS Vdd P<sub>RDS</sub> [mW] **[m**Ω] [mV] [A] [mV] **[m**Ω] [V] [mA] [V] [mA] Out 1A 0.5153 100 51.53 65.88 33.947964 127.84786 8.4 19.6 3.3 31 Out 1B 100 51.53 0.5153 72.89 37.560217 141.45158 Out 2A 100 51.42 0.5142 73.43 37.757706 142.80436 Out 2B 100 51.65 0.5165 67.28 34.75012 130.26137

### STA333IS: 500 mA output current and 2-layer PCB - current measurement Table 1.

Table 2.	STA333IS: 500 mA out	out current and 2-lay	yer PCB -	power dissipation
----------	----------------------	-----------------------	-----------	-------------------

Power_Output [W]	0.14402	W
Power_Vdd [W]	0.1023	W
Power_Vcc [W]	0.16464	W

#### Figure 2. STA333IS: 500 mA output current and 2-layer PCB - thermal measurement

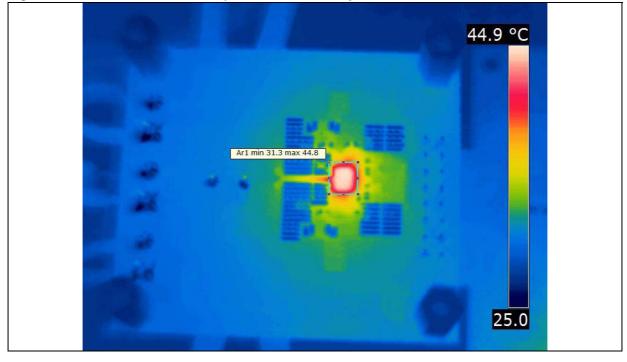


Table 3. 51A33315: 500 mA 0	utput current and 2-layer PCB - s	summary table
Total power [W]	0.41096	W
Temperature (case) [°C]	44.8	°C
Temperature (ambient) [°C]	26	°C
R <sub>th</sub> [k/W]	45.747	°C/W

Table 3. STA333IS: 500 mA output current and 2-layer PCB - summary table

### 3.2 STA333IS: 1000 mA output current and 2-layer PCB

Table 4. STA333IS: 1000 mA output current and 2-layer PCB - current measurement

	R <sub>sense</sub> [mΩ]	V_R <sub>sense</sub> [mV]	I_Channel [A]	V <sub>RDS</sub> [mV]	P <sub>RDS</sub> [mW]	RDS [mΩ]	Vcc [V]	I_Vcc [mA]	Vdd [V]	I_Vdd [mA]
Out 1A	100	102.8	1.028	147.7	151.8356	143.67704	17.05	19.87	3.3	32
Out 1B	100	103.9	1.039	162.63	168.97257	156.52551				
Out 2A	100	103.7	1.037	163.1	169.1347	157.28062				
Out 2B	100	104.24	1.0424	149.63	155.97431	143.54375				

### Table 5. STA333IS: 1000 mA output current and 2-layer PCB - power dissipation

Power_Output [W]	0.64592	W
Power_Vdd [W]	0.1056	W
Power_Vcc [W]	0.33878	W

### Figure 3. STA333IS: 1000 mA output current and 2-layer PCB 2 - thermal measurement

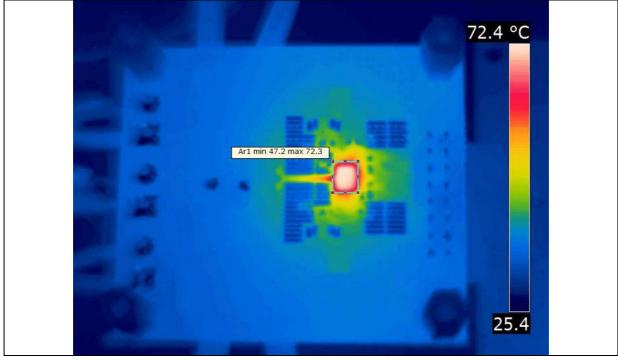




Table 6. STA333IS: 1000 m/	A output current and 2-layer PCB -	summary table
Total power [W]	1.0903	w
Temperature (case) [°C]	72.3	°C
Temperature (ambient) [°C]	24	°C
R <sub>th</sub> [k/W]	44.300	°C/W

Tá

#### 3.3 STA333IS: 500 mA output current and 4-layer PCB

Table 7. STA333IS: 500 mA output current and 4-layer PCB - current measurement

	R <sub>sense</sub> [mΩ]	V_R <sub>sense</sub> [mV]	I_Channel [A]	V <sub>RDS</sub> [mV]	P <sub>RDS</sub> [mW]	RDS [mΩ]	Vcc [V]	I_Vcc [mA]	Vdd [V]	l_Vdd [mA]
Out 1A	100	51.1	0.511	65.15	33.29165	127.49511	8.36	19.21	3.3	32
Out 1B	100	50.46	0.5046	69.55	35.09493	137.83195				
Out 2A	100	50.94	0.5094	69.9	35.60706	137.22026				
Out 2B	100	51.1	0.511	64.8	33.1128	126.81018				

#### Table 8. STA333IS: 500 mA output current and 4-layer PCB - power dissipation

Power_Output [W]	0.13711	W
Power_Vdd [W]	0.1056	W
Power_Vcc [W]	0.1606	W





57

Table 9. 51A33315: 500 mA 0	utput current and 4-layer PCB - s	summary table
Total power [W]	0.4033	W
Temperature (case) [°C]	42	°C
Temperature (ambient) [°C]	26	°C
R <sub>th</sub> [k/W]	39.672	°C/W

Table 9. STA333IS: 500 mA output current and 4-layer PCB - summary table

## 3.4 STA333IS: 1000 mA output current and 4-layer PCB

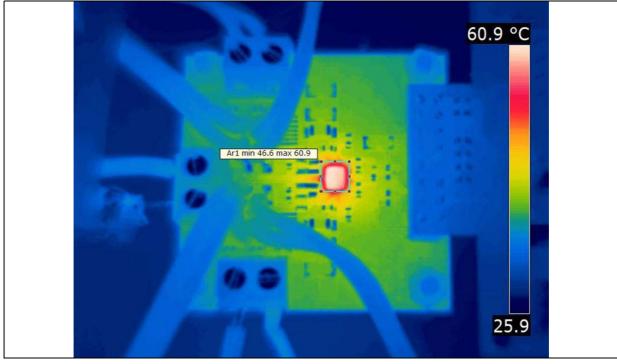
Table 10. STA333IS: 1000 mA output current and 4-layer PCB - current measurement

	R <sub>sense</sub> [mΩ]	V_R <sub>sense</sub> [mV]	I_Channel [A]	V <sub>RDS</sub> [mV]	P <sub>RDS</sub> [mW]	RDS [mΩ]	Vcc [V]	I_Vcc [mA]	Vdd [V]	I_Vdd [mA]
Out 1A	100	101.8	1.018	137	139.466	134.5776	16.58	19.5	3.3	32
Out 1B	100	100.5	1.005	146.5	147.2325	145.77114				
Out 2A	100	101.4	1.014	147.5	149.565	145.46351				
Out 2B	100	101.9	1.019	137	139.603	134.44553				

Table 11.	STA333IS: 1000 mA output current and 4-layer PCB - power dissipation
-----------	--

Power_Output [W]	0.57587	W
Power_Vdd [W]	0.1056	W
Power_Vcc [W]	0.32331	W





Total power [W]	1.00478	W
Temperature (case) [°C]	60.9	°C
Temperature (ambient) [°C]	26	°C
R <sub>th</sub> [k/W]	34.734	°C/W

 Table 12.
 STA333IS: 1000 mA output current and 4-layer PCB - summary table

# 4 Conclusion

This methodology is very simple to implement because it measures only DC current and voltage levels. The result achieved is very reliable.

The flexibility and the easy configurability of the external components allow implementing tests with any output current level, estimating the thermal behavior with the operating condition using the same PCB used in the final application.

Another positive aspect is that this methodology provides an estimation of the combination of RDSon + output PCB tracks. This data is useful for evaluating the proper connection of the output pads or balls.



# 5 Revision history

### Table 13. Document revision history

Date	Revision	Changes
16-Jan-2013	1	Initial release.



### Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY TWO AUTHORIZED ST REPRESENTATIVES, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2013 STMicroelectronics - All rights reserved

### STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

